

## **Search Notes**



**Application/Control No.**

-10/684,829

## **Examiner**

John T. Kwon

**Applicant(s)/Patent under  
Reexamination**

CHMELA ET AL.

## **Art Unit**

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	299	11/28/2005	JK
	305		
	294		
	501		
	568.14		
	301		
	568.21		
	updated	4/27/2006	JK

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner